## : ©hipsmall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts,Customers Priority,Honest Operation, and Considerate Service",our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!


## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832
Email \& Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, \#122 Zhenhua RD., Futian, Shenzhen, China


Electrical Characteristics ( $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| STATIC PARAMETERS |  |  |  |  |  |  |
| BV ${ }_{\text {DSS }}$ | Drain-Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | -30 |  |  | V |
| ISs | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=-30 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  | -1 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{T}_{\mathrm{J}}=55^{\circ} \mathrm{C}$ |  |  | -5 |  |
| IGSS | Gate-Body leakage current | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 25 \mathrm{~V}$ |  |  | $\pm 100$ | nA |
| $\mathrm{V}_{\mathrm{GS}(\text { (th) }}$ | Gate Threshold Voltage | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}} \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ | -1.7 | -2.3 | -2.8 | V |
| $\mathrm{I}_{\mathrm{D}(\mathrm{ON})}$ | On state drain current | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=-5 \mathrm{~V}$ | -50 |  |  | A |
| $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}$ | Static Drain-Source On-Resistance | $\mathrm{V}_{\mathrm{GS}}=-20 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9 \mathrm{~A}$ |  | 10 | 15 | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-8 \mathrm{~A}$ |  | 12 | 18 | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | 13 | 20 |  |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-5 \mathrm{~A}$ |  | 29 |  | $\mathrm{m} \Omega$ |
| $\mathrm{g}_{\mathrm{FS}}$ | Forward Transconductance | $\mathrm{V}_{\text {DS }}=-5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9 \mathrm{~A}$ |  | 27 |  | S |
| $\mathrm{V}_{\text {SD }}$ | Diode Forward Voltage | $\mathrm{I}_{\mathrm{S}}=-1 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | -0.7 | -1 | V |
| $\mathrm{I}^{\text {S }}$ | Maximum Body-Diode Continuous Current |  |  |  | -2.5 | A |
| DYNAMIC PARAMETERS |  |  |  |  |  |  |
| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |  | 2060 | 2600 | pF |
| $\mathrm{C}_{\text {oss }}$ | Output Capacitance |  |  | 370 |  | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  |  | 295 |  | pF |
| $\mathrm{R}_{\mathrm{g}}$ | Gate resistance | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ | 1.2 | 2.4 | 3.6 | $\Omega$ |
| SWITCHING PARAMETERS |  |  |  |  |  |  |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-9 \mathrm{~A}$ |  | 30 | 39 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ |  |  |  | 4.6 |  | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate Drain Charge |  |  | 10 |  | nC |
| $\mathrm{t}_{\mathrm{D} \text { (on) }}$ | Turn-On DelayTime | $\begin{aligned} & \mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=1.67 \Omega, \\ & \mathrm{R}_{\mathrm{GEN}}=3 \Omega \end{aligned}$ |  | 11 |  | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Turn-On Rise Time |  |  | 9.4 |  | ns |
| $\mathrm{t}_{\text {(offit }}$ | Turn-Off DelayTime |  |  | 24 |  | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Turn-Off Fall Time |  |  | 12 |  | ns |
| $\mathrm{t}_{\mathrm{rr}}$ | Body Diode Reverse Recovery Time |  |  | 30 | 40 | ns |
| $\mathrm{Q}_{\mathrm{rr}}$ | Body Diode Reverse Recovery Charge | $\mathrm{I}_{\mathrm{F}}=-9 \mathrm{~A}, \mathrm{dl} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ |  | 22 |  | nC |

$A$. The value of $R_{\theta J A}$ is measured with the device mounted on $1 \mathrm{in}^{2}$ FR-4 board with 2 oz . Copper, in a still air environment with $T_{A}=25^{\circ} C$. The value in any given application depends on the user's specific board design.
B. The power dissipation $P_{D}$ is based on $T_{J M A X)}=150^{\circ} \mathrm{C}$, using $\leqslant 10$ s junction-to-ambient thermal resistance.
C. Repetitive rating, pulse width limited by junction temperature $\mathrm{T}_{\mathrm{J}(\mathrm{MAX)}}=150^{\circ} \mathrm{C}$. Ratings are based on low frequency and duty cycles to keep initialT ${ }_{J}=25^{\circ}$ C.
D. The $R_{\text {өJA }}$ is the sum of the thermal impedence from junction to lead $R_{\text {өJL }}$ and lead to ambient.
E. The static characteristics in Figures 1 to 6 are obtained using $<300 \mu$ s pulses, duty cycle $0.5 \%$ max.
F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on $1 \mathrm{in}^{2}$ FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $\mathrm{T}_{\mathrm{JMAX})}=150^{\circ} \mathrm{C}$. The SOA curve provides a single pulse rating.

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Fig 1: On-Region Characteristics (Note E)


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)


Figure 2: Transfer Characteristics (Note E)


Figure 4: On-Resistance vs. Junction Temperature (Note E)


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

Gate Charge Test Circuit \& Waveform



Resistive Switching Test Circuit \& Waveforms


Diode Recovery Test Circuit \& Waveforms


